Search Notes



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Applicant(s)/Patent Under Reexamination

BRIQUE ET AL.

Examiner

SHIN-HON CHEN

Art Unit 2131

SEARCHED

Class	Subclass	Date	Examiner
380	231,239	7/5/07	S.C.
713	193	7/5/07	S.C.

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Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search	7/5/07	S.C.
history)		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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